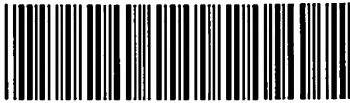


Search Notes

Application/Control No.

10/649,026

Examiner

Alvin C. Chin-Shue

Applicant(s)/Patent under
Reexamination

MEEKER, PAUL K.

Art Unit

3634

SEARCHED

Class	Subclass	Date	Examiner
<i>update</i>		<i>83.05</i>	<i>As</i>

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR